

Notice of References Cited	Application/Control No. 10/073,876	Applicant(s)/Patent Under Reexamination OSAKA ET AL.	
	Examiner Janice L. Krizek	Art Unit 3652	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,775,281	10-1988	Prentakis, Antonios E.	414/416.03
*	B	US-5,100,502	03-1992	Murdoch et al.	414/744.1
	C	US-5,102,291	04-1992	Hine, Derek L.	414/816
	D	US-5,405,230	04-1995	Ono et al.	414/217
*	E	US-5,954,072	09-1999	Matusita, Mitiaki	134/149
*	F	US-5,989,342	11-1999	Ikeda et al.	118/52
*	G	US-6,052,913	04-2000	Kaneko et al.	33/645
*	H	US-6,203,268 B1	03-2001	Miyashita, Masahiro	414/757
*	I	US-6,222,991 B1	04-2001	Davenport, Robert E.	392/418
*	J	US-6,247,245 B1	06-2001	Ishii, Katsumi	34/82
*	K	US-6,368,049 B1	04-2002	Osaka et al.	414/783
*	L	US-6,658,321 B2	12-2003	Osaka et al.	700/218
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 6-140492	05-1994	Japan	---	---
*	O	JP 6-334026	12-1994	Japan	---	---
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.